

# Properties of excitonic states in MOCVD-grown Zn(Cd)Se/ZnMgSSe quantum wells with spreaded heterointerfaces

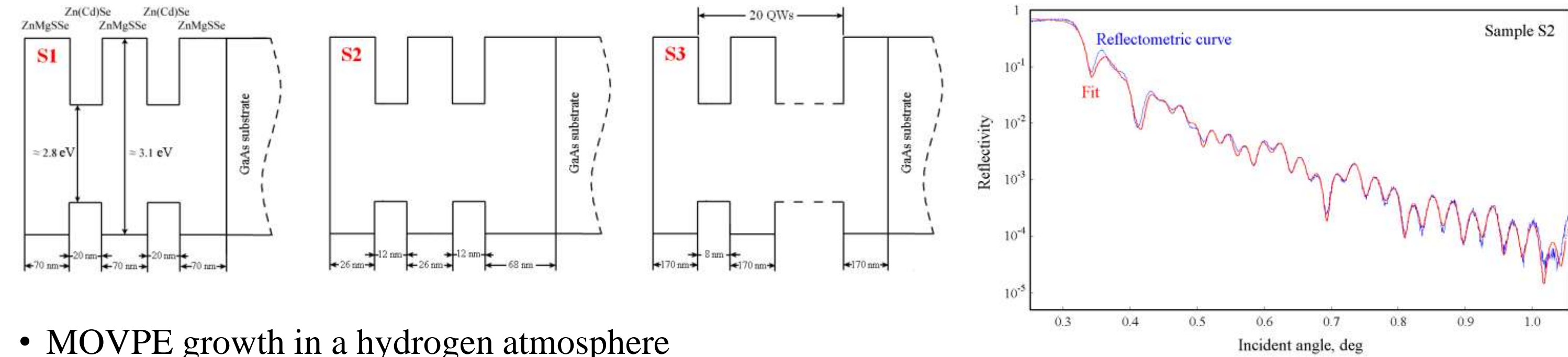
*A.F. Adiyatullin<sup>1,2</sup>, S.V. Shevtsov<sup>1,2</sup>, A.N. Minnullin<sup>2</sup> and V.S. Krivobok<sup>1,2\*</sup>*

<sup>1</sup>P.N. Lebedev Physical Institute, Russian Academy of Sciences, Moscow, 119991 Russia; <sup>2</sup>Moscow Institute of Physics and Technology (State University), Dolgoprudny, 141700 Russia; \*e-mail: [krivobok@lebedev.ru](mailto:krivobok@lebedev.ru)

## Motivation

- In contrast to the model QW heterointerface, real interface is often characterized by diffusion broadening and disorder, affecting the electronic and optical properties of QWs.
- Electronic properties of heterovalent ZnSe/GaAs interface depend strongly on the structure of Ga-Se and Zn-As bindings. They result in specific band bending promoting charge redistribution in the structure. QWs act as additional carrier reservoirs helping in understanding of ZnSe/GaAs interface features.
- Properties of real interfaces are of crucial interest for development of electronic devices. Being a wide-bandgap semiconductor, ZnSe is promising for several optoelectronic applications.

## Samples



- MOVPE growth in a hydrogen atmosphere at 85 Torr and 450 °C.
- Samples with two QWs: the bottom one had been held at a high growth temperature longer than the top QW, which led to the **different diffusion blurring of QWs**.
- S2**: best fit of X-ray reflectometry curve reproduces interface blurring 1.5 nm for bottom QW and <0.5 nm for the top one.

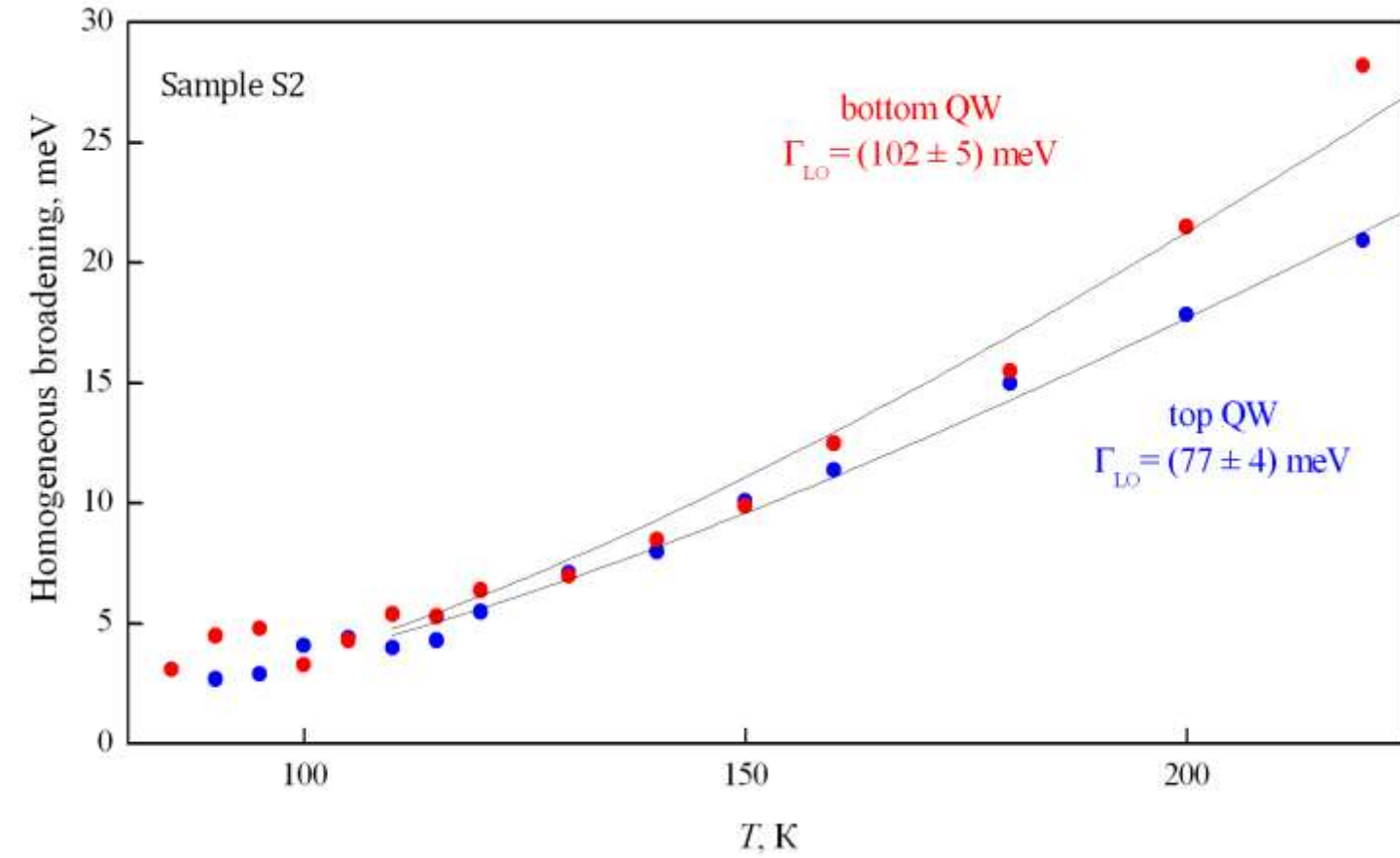
## Exciton emission spectra

Resonances in PL and photoreflectance spectra:

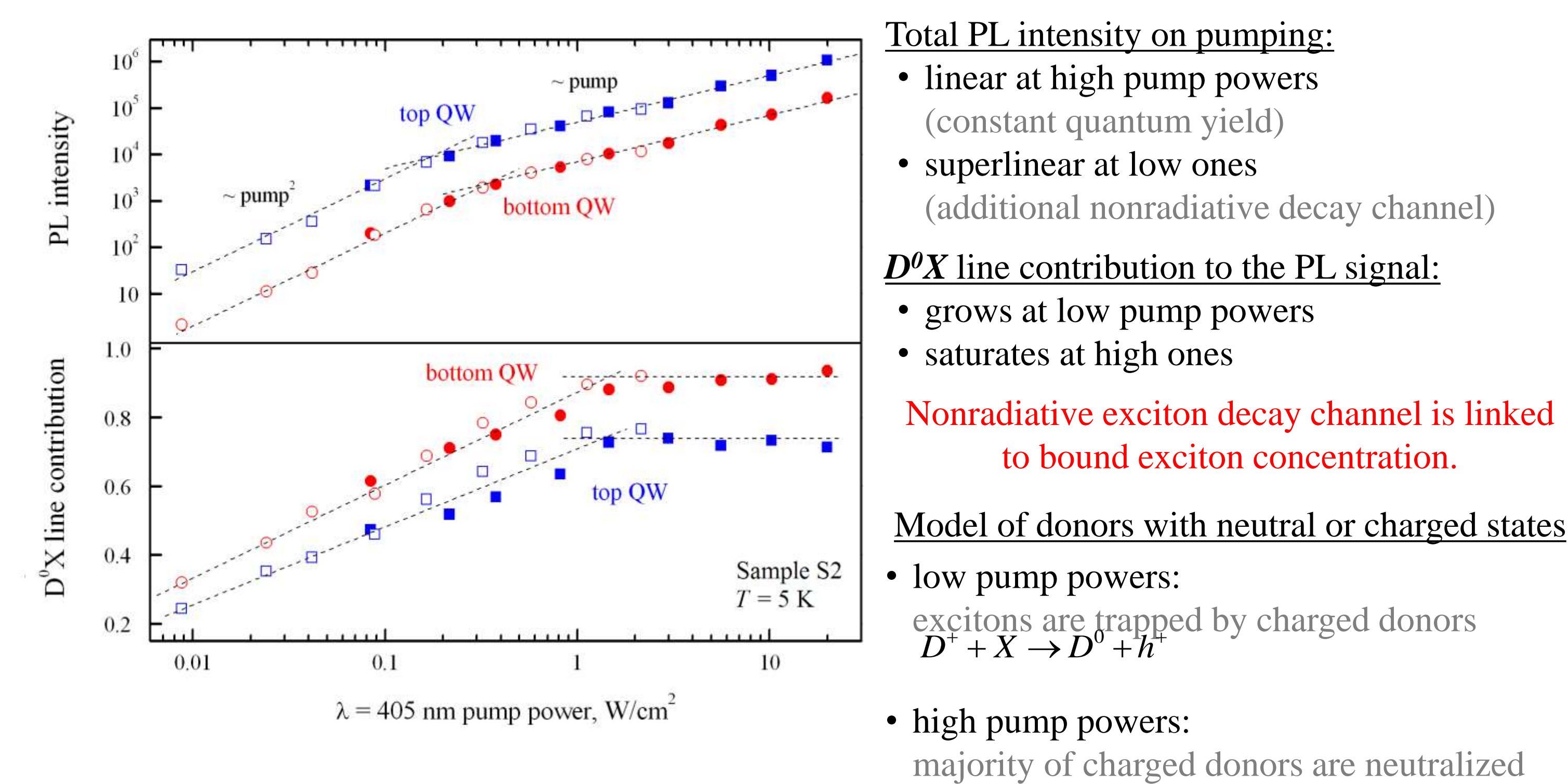
- Free excitons with heavy hole ( $X$ ), light hole ( $X_{lh}$ ), excited state for light-hole exciton ( $X_{lh}^*$ ) **hh-lh** splitting 25 meV,  $X_{lh}$  excitation energy 17 meV, corresponding to theoretical calculations
- Excitons bound on neutral donors ( $D^0X$ )
- Deep acceptor related transitions ( $DA$ )

## Exciton-phonon interaction

- X line homogeneous broadening
 
$$\Gamma_L(T) = \Gamma_0 + \Gamma_{ac}T + \frac{\Gamma_{Lo}}{\exp(\hbar\omega_{Lo}/kT)}$$
- Interface blurring results in enhancement of exciton-LO phonon interaction (Fröhlich mechanism)
- Different effective masses and barrier heights for  $e^-$  and  $h^+$  in QW
  - different degree of  $e^-$  and  $h^+$  penetration in the barrier
  - local exciton polarization enhancing Fröhlich interaction**



## Nonradiative exciton decay channel



Total PL intensity on pumping:

- linear at high pump powers (constant quantum yield)
- superlinear at low ones (additional nonradiative decay channel)

**$D^0X$  line contribution to the PL signal:**

- grows at low pump powers
- saturates at high ones

**Nonradiative exciton decay channel is linked to bound exciton concentration.**

**Model of donors with neutral or charged states**

- low pump powers: excitons are trapped by charged donors  $D^+ + X \rightarrow D^0 + h^+$
- high pump powers: majority of charged donors are neutralized

## Heterointerface influence on bound exciton binding energy

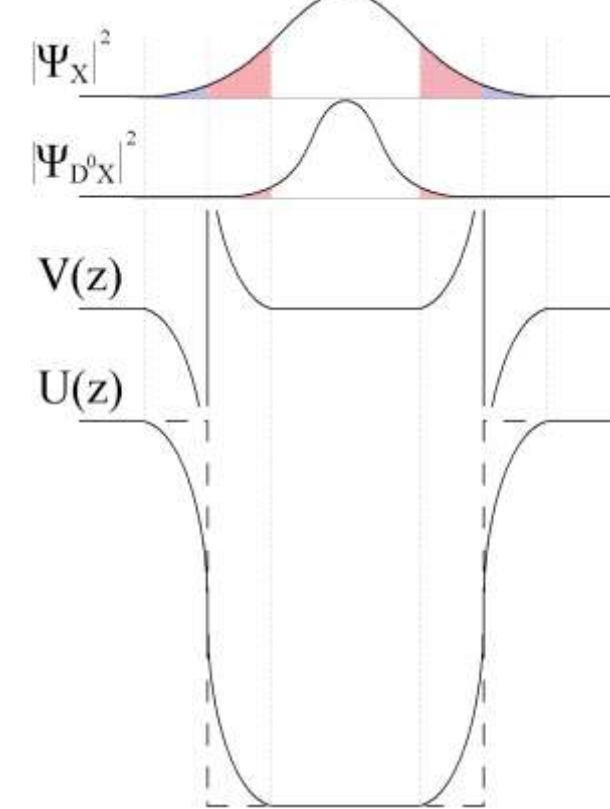
Heterointerface spreading is a small perturbation  $V$  of the ideal rectangular QW potential, leading to the shift of free and bound exciton energy levels:

$$\Delta E_X = \langle \Psi_X | V | \Psi_X \rangle, \Delta E_{D^0X} = \langle \Psi_{D^0X} | V | \Psi_{D^0X} \rangle$$

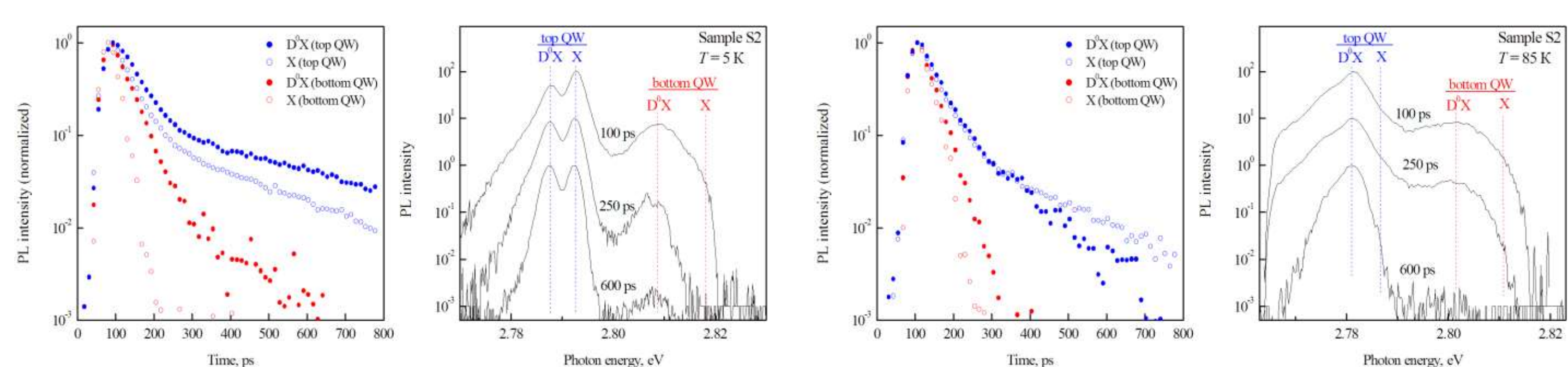
$\Psi_{D^0X}$  is localized more than  $\Psi_X$  and is hardly affected by the perturbation. Total energy shift is determined by  $\Delta E_X$

$$\Delta E_X \gg \Delta E_{D^0X} \Rightarrow \Delta E_{total} = \Delta E_X - \Delta E_{D^0X} \approx \Delta E_X$$

rising with heterointerfaces blurring.



## PL dynamics



Bi-exponential PL decay:

- $t_{fast} \sim 30-50$  ps – exciton trapping by  $D^+$
- $t_{slow} \sim 200-400$  ps – radiative lifetime, vanishes with temperature growth due to thermal escape of excitons

$t_{slow}$  vanishes at lower temperature for the bottom QW

**increase of defects and charged/neutral donors concentration with interface blurring**

## Broadening of exciton emission line

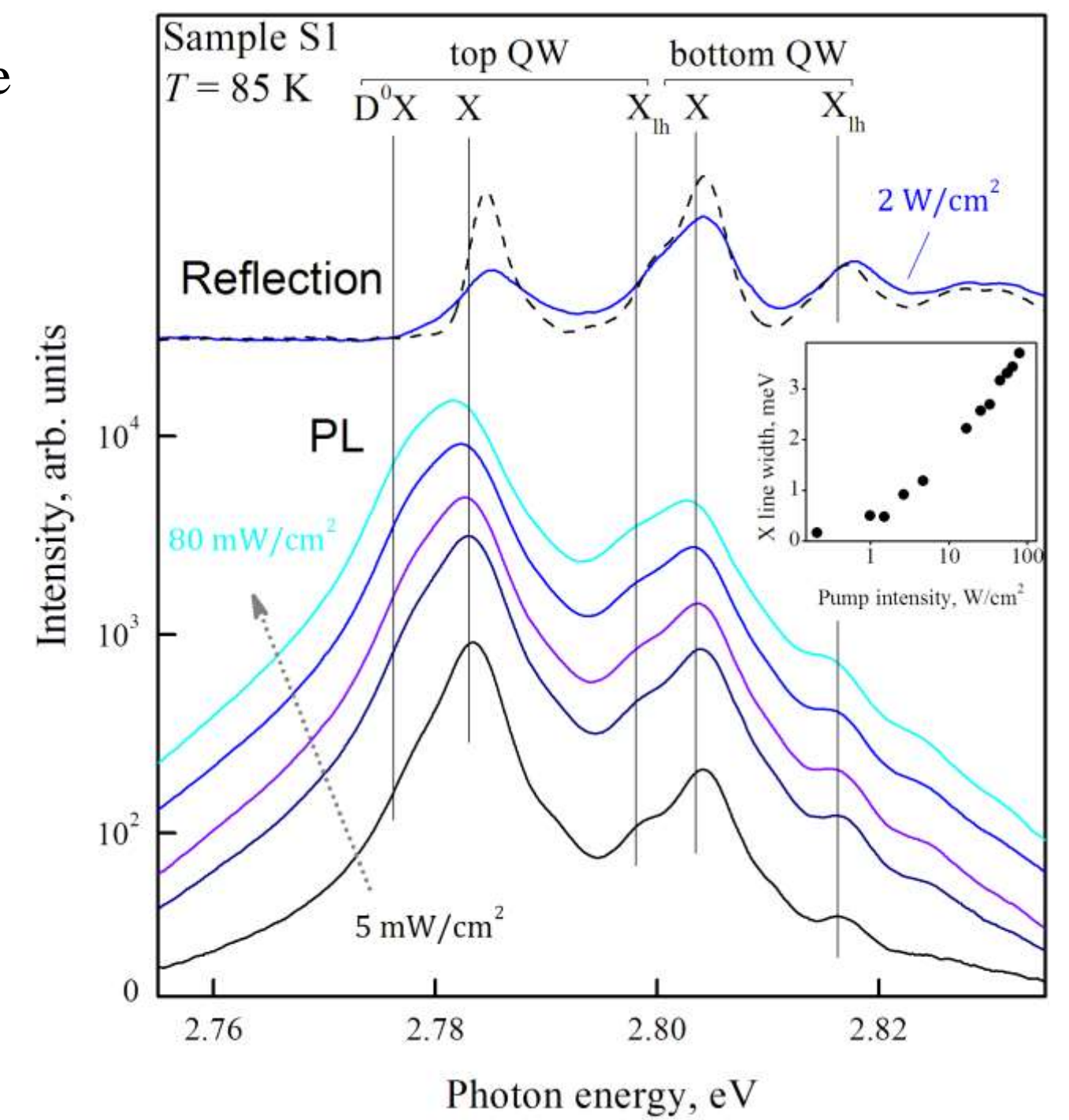
- Increase in pump power leads to the broadening of  $X$  line in PL spectra as well as corresponding resonances in reflectance spectra.

- According to Saha equation  $n_X < 0.15 n_e$

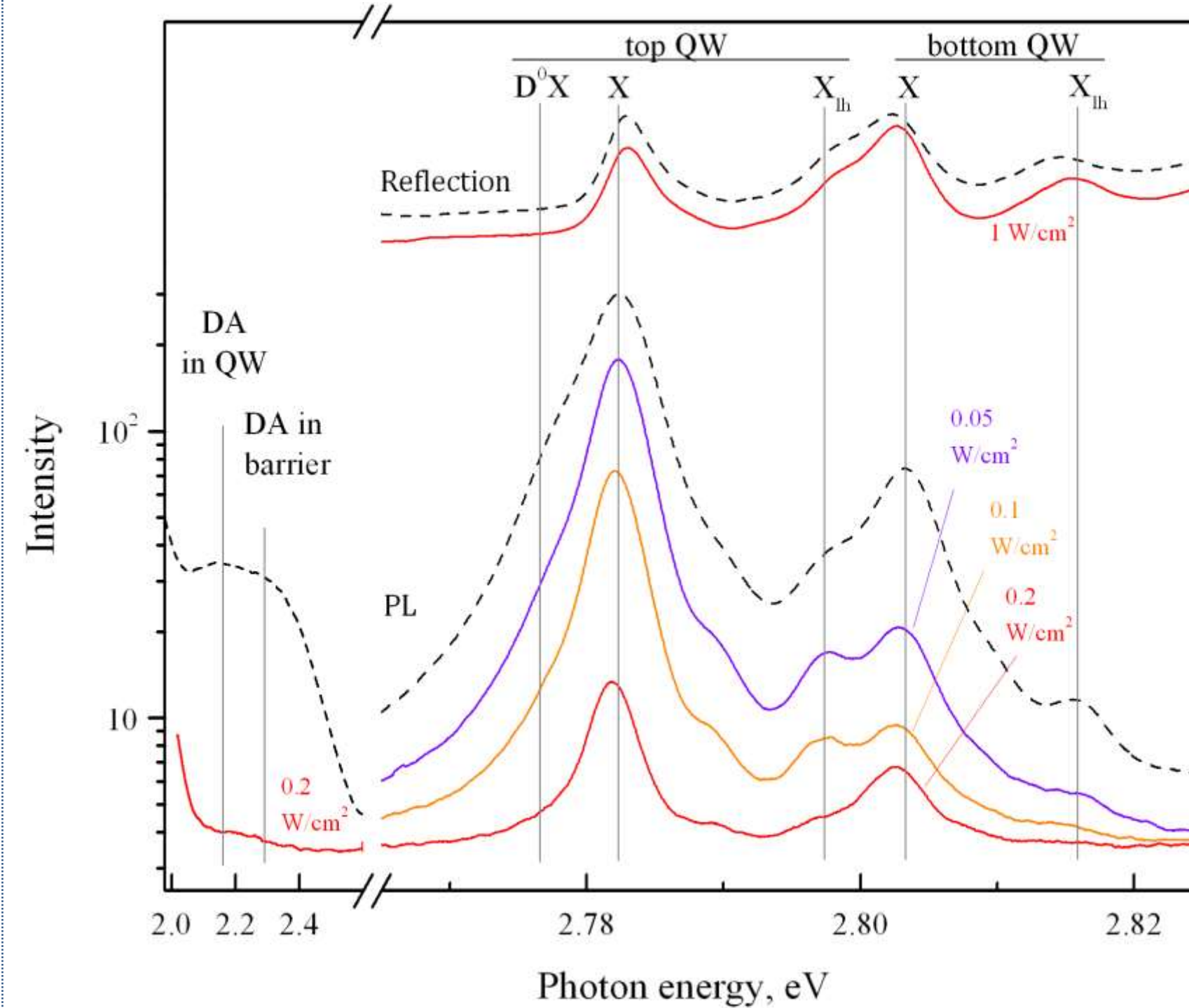
exciton-electron scattering plays a major role in  $X$  line broadening

- From the X line broadening:  $n_e \sim 10^{11} \text{ cm}^{-2}$   
Photoinduced carrier concentration:  $n_e \sim 10^9 \text{ cm}^{-2}$

**increase in pump power leads to excess electron concentration in QW**



## Effect of below-barrier illumination on excitonic states



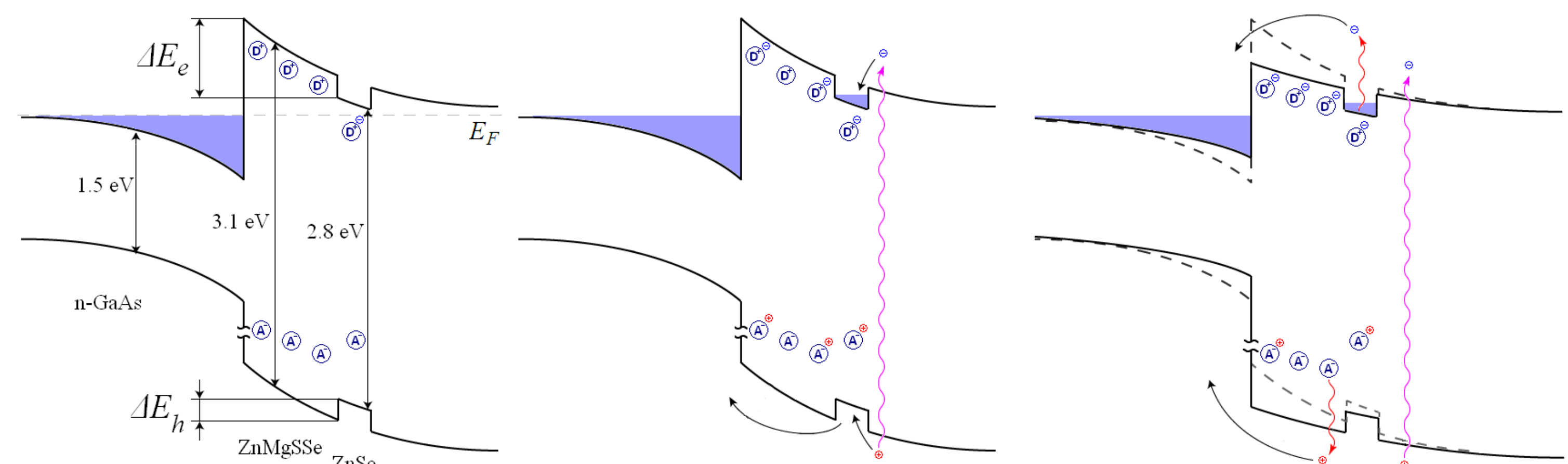
Effects at low pump powers and  $T \sim 100$  K:

- (1) drastic decrease of PL quantum yield;
- (2)  $D^0X$  line disappearance;
- (3)  $X$  line narrowing.

Illumination leads to  $n_e$  decrease

- according to Saha equation for  $D^+ + e^- \leftrightarrow D^0$  number of  $D^+$  (nonradiative decay centers) increases
- number of  $D^0$  decreases
- $X$  line is narrowed due to electron-exciton scattering reduction

## ZnMgSSe/GaAs heterointerface



- Interdiffusion of Zn and Ga atoms during the growth

- Band bending due to ionized Ga donors in ZnMgSSe layer**

- Barrier in conductivity band preventing  $e^-$  flow to the substrate; no barrier for  $h^+$**
- Excess  $e^-$  concentration in QWs

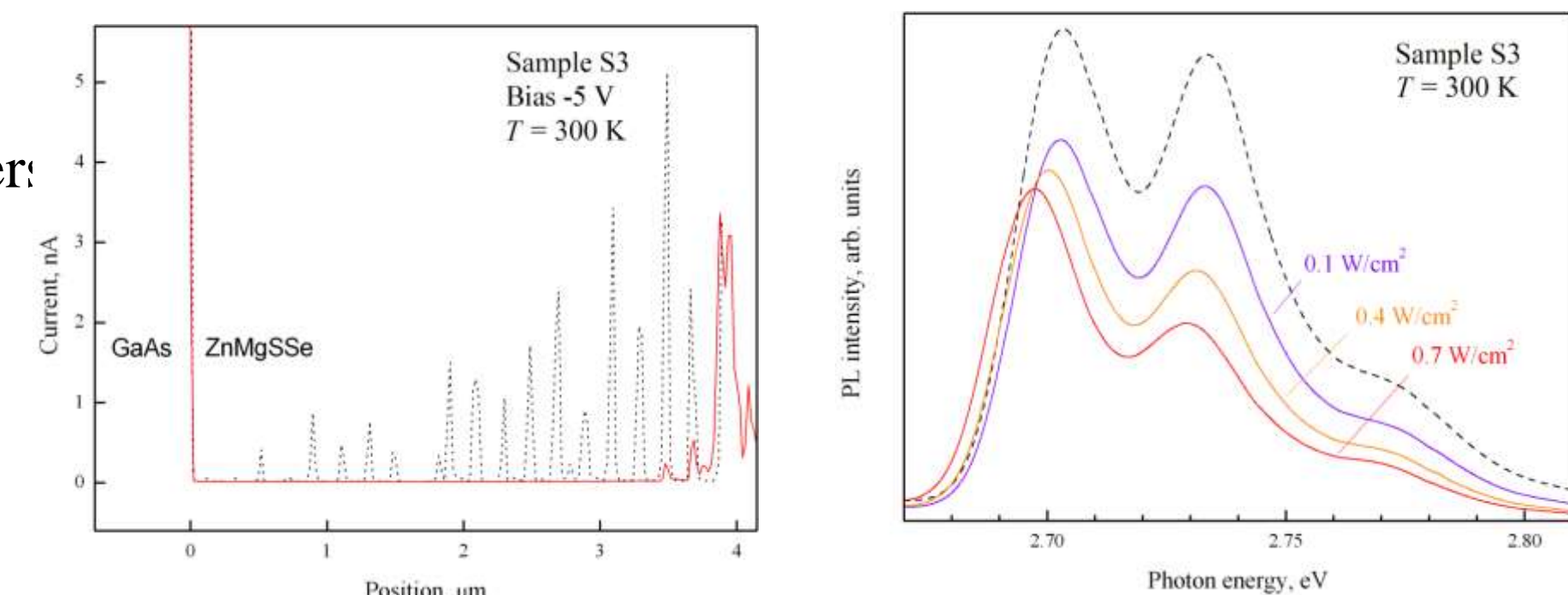
Possible effects of below-barrier illumination on excess  $n_e$ :

- decrease of the barrier height due to deep acceptor ionization
- free electron absorption

## SSRM measurements with additional illumination

- In the dark:** no current through ZnSe/ZnMgSSe layer:
- Under the optical pumping:**  $e^-$  current from the QWs, no current from barrier layers
- Additional below-barrier illumination:** decrease in  $e^-$  electronic current from QWs as well as decrease in PL quantum yield

**Optical pumping leads to the electron accumulation in QWs.**  
**Additional below-barrier illumination causes decrease of excess electron concentration in QWs.**



## Conclusion

- ZnSe/ZnMgSSe QW heterointerfaces blurring leads to:
  - enhancement of Fröhlich interaction due to the induced exciton polarization;
  - increase in  $X-D^0X$  line distance due to different degree of localization of free and bound excitons on the heterointerface;
  - increase in concentration of neutral and charged defects.
- The major exciton nonradiative decay channel is trapping on charged donors.
- Under excitation an excess electron concentration in QWs due to band bending on ZnMgSSe/GaAs interface is presented.
- Additional below-barrier illumination leads to the disappearance of excess electron concentration in QWs, resulting in
  - dramatic decrease in PL quantum yield due to increase in number of  $D^+$  centers;
  - disappearance of  $D^0X$  line caused by decrease in number of  $D^0$  centers;
  - narrowing of  $X$  line due to decrease of exciton-electron scattering role.
- Charge redistribution processes are confirmed by the measurements of scanning spreading resistance microscopy with additional illumination.